

Notice of References Cited	Application/Control No. 10/539,892		Applicant(s)/Patent Under Reexamination XU ET AL.	
	Examiner Timothy J. Henn		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,512,575	01-2003	Marchi, Paolo	356/5.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 4439298 A1	06-1996	Germany	SCHWARTE, RUDOLF PROF DR	
	O					
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Lange et al.; Time-of-flight range imaging with a custom solid-state image sensor; 1999; Laser Metrology and Inspection, Proc. SPIE, Vol. 3823
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.